

Application/Control No.
10/813,426

Examiner
Jason M. Nolan, Ph.D.

Applicant(s)/Patent under Reexamination
ALCARAZ ET AL.

Art Unit 1626

		ORIGINAL				INTERNATIONAL CLASSIFICATION									
	CLASS	LASS CLAIMED						NON-CLAIMED							
	514		620		С	07	ပ	233	/35		/				
	CROS	S REFERE	NCES		С	07	С	237	/30		,				
CLASS	SUBCLA	SS (ONE S	JBCLASS PE	R BLOCK)											
514	623				Α	61	ĸ	31	/166	1	/				
564	164 188				Α (61	к	31	/165		1				
									ī		1				
									1		1				
									1		1				
	. Nolan, F			KAMA PRIM		AEED EXAM	-		To	otal Claims Al	lowed: 22				
(Assi	ştant Exam	iner) (D	ate)	1		~() <		,							

Jason M. Nolan, Ph.D. 6/13/2006
(Assistant Examiner)

PRIMARY EXAMINER

(Primary Examiner)

(Date)

Claims renumbered in the same order as presented by applicant

Examiner | Ex

Ë	Orig		ᄩ	Orig		iĒ	Orig		ιĒ	Orig	ᇤ	Orig	ίĒ	Orig	Fi	Orig
1	1	1	21	31			61	1		91		121		151		181
2	2	1	22	32	1		62]		92		122		152		182
3	3			33			63]		93		123		153		183
4	4			34			64]		94		124		154		184
	5-			35			65]		95		125		155		185
6	6			36			66			96		126		156		186
				37			67			97		127		157		187
	-8-			38			68			98		128		158		188
	9-			39		l i	69			99		129	7	159		189
7	10		li a	40			70			100		130		160		190
8	11			41			71			101		131		161		191
9	12			42			72			102		132		162		192
10	13]		43			73			103		133		163		193
	-14	}		44]		74			104		134		164		194
	15]		45]		75			105		135		165		195
	18			46			76			106		136		166		196
	117			47			77			107		137		167		197
	18]		48			78			108		138		168		198
	19			49			79			109		139		169		199
	-20	1		50			80	}		110		140		170		200
11	21]		51]		81]		111		141		171		201
12	22	}		52]		82			112		142		172		202
13	23]		53]		83			113		143		173		203
14	24			54			84			114		144		174		204
15	25			55]		85			115		145		175		205
16				56			86			116		146		176		206
17				57			87]		117		147		177		207
18	28			58			88			118		148		178		208
19				59]		89]		119		149		179		209
20	30			60	1		90			120		150		180		210